

Application/Control No.	Applicant(s)/Patent under Reexamination KAKUDA ET AL.	
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Examiner	Art Unit	
Brian Nash	3721	

SEARCHED					
Class	Subclass	Date	Examiner		
227	120,119, 121,123	2/10/2005	BN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
227	US PGPub	8/27/2005	BN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
227 (US patents only) text, invntr, IDS via EAST, updated 8-27-05	8/27/2005	BN		
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